

Supporting Information

Characterization of Vertically Aligned Carbon Nanotube Forests Grown on Stainless Steel Surfaces

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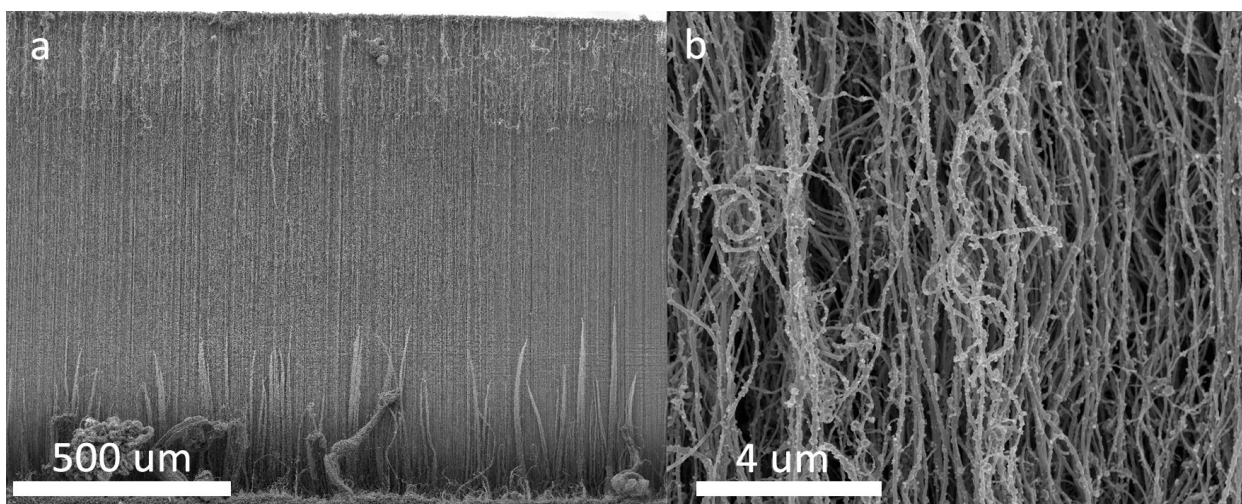


Figure 1. SEM images of CNT forest grown on silicon.